

**Notice of References Cited**

Application/Control No.

09/911,522

Applicant(s)/Patent Under  
Reexamination  
BUSHEE ET AL.

Examiner

Chongshan Chen

Art Unit

2172

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,018,733	01-2000	Kirsch et al.	707/3
	B	US-6,553,364	04-2003	Wu, Jiong	707/1
	C	US-6,237,011	05-2001	Ferguson et al.	715/515
	D	US-6,078,914	06-2000	Redfern, Darren M.	707/3
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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